

# Interconnection studies for SiW Ecal

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#### The goal is realize interconnection of ASUs for Technology prototype



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#### **ASU interconnection by soldering**



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#### ASU interconnection with ACF **3M** Anisotropic Conductive Film adhesives





### ASU interconnection with ACF **3M** Anisotropic Conductive Film adhesives



Positioning ACF on boards and positioning kapton combs



#### Using Myachi Thermode



Temperature 150°C Time 25 seconds Pressure 1,8 MPa



#### ASU interconnection with ACF **3M** Anisotropic Conductive Film adhesives

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	5	2.5	5		5	0.3	5	0.2	5	0.3	5	0.3	5	0.3	5	0.3	5		5		5	1.2	5	1.3	
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	9	0.6	9		9	0.3	9	0.3	9	0.4	9	0.3	9	0.3	9	0.3	9	1.8	9		9	1.3	9	1.3	
	10		10		10	0.3	10	0.3	10	0.3	10	0.3	10	0.3	10	0.3	10	_	10	_	10	1.3	10	1.3	
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	12		12	1,5	12	0.3	12	0.3	12	0.3	12	0.3	12	0.3	12	0.3	12	_	12	2.7	12	1.3	12	1.3	
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15 4 V	21		21		21	0.3	21	0.3	21	0.3	21	0.3	21	0.3	21	0.3	21		21		21	1.3	21	13	
Post of	22		22		22	0.3	22	0.3	22	0.4	22	0.3	22	0.3	22	0.3	22		22		22	1.3	22	1.4	
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	25		25		25	0.3	25	0.3	25	0.3	25	0.4	25	0.3	25	0.3	25		25		25	1.3	25	1.3	
	26		26		26	0.3	26	0.3	26	0.3	26	0.3	26	0.4	26	0.5	26		26		26	1.4	26	1.6	
	27		27		27	0.3	27	0.3	27	0.4	27	0.3	27	0.3	27	0.3	27		27		27	1.3	27	1.4	
	28		28		28	0.3	28	0.7	28	0.3	28	0.3	28	0.3	28	0.5	28		28		28	1.3	28	2.2	1212122
	29		29		29	0.4	29	0.3	29	0.3	29	0.3	29	0.3	29	0.4	29		29		29	1.3	29	1.4	
	30		30		30	0.4	30	0.4	30	0.2	30	0.3	30	0.4	30	0.4	30		30		30	1.5	30	1.6	0
	31		31		31	0.3	31	0.8	31	0.3	31	0.3	31	0.3	31	0.3	31		31		31	1.3	31	2	
			32		22	0.3	32	2.8	32	0.3	32	0.3	32	0.4	32	0.3	32		32		32	1.3	32	3.8	
	32		32		36	0.5	26																		
	32 33		33	2	33	0.5	33	0.6	33	0.3	33	1.3	33	0.4	33	1	33		33		33	1.6	33	2.3	
	32 33 34		33 34	2 0.7	33 34	0.5 0.4	33 34	0.6	33	0.3	33 34	1.3 0.4	33 34	0.4 0.3	33 34	1 0.6	33 34		33 34	2.5	33 34	1.6 1.5	33 34	2.3 1.7	

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Made with a precision multimeter Keithley Resistance between wires in PCB = 0.21 ohms Isolation between wires in PCB =  $\infty$  HV tests







#### 1 wire with Max 1350V between 2 ground wires





#### **Tensile tests**

2x small PCBs with 36 wires interconnected by 2 kaptons and series connections





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Technology	Advantages	Disadvantages						
N°1 Solder	-Proven technology -Possible to repair -~3 euros/connector	-Difficult procedure -Too much heat for the glue of wafers -Cannot be industrialized						
N°2 ACF	-Easy to install -Easy to remove -Easy to industrialize	<ul> <li>-Needs to have a perfect planarity</li> <li>-Needs to have a thermode ~15Keuros</li> <li>-10mA maximum per wire</li> <li>-~30 euros/connector</li> <li>-Too much pressure</li> <li>=mechanical stress for the wafers</li> </ul>						
N°3 Spécial Kapton	-Easy to install -Good reliability -Possible to repair -Easy to industrialize -Good strength -~4 euros/connector	-I don't know yet						

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- Test solution n°3 (special kapton) with a manipulator system, was delivered before this conference and is ready for settings.
- Realize the interconnection of 1ASU+1Adapter-card+1DIF for summer test beam



Can easily be automated

- Study a new long HV kapton and short HV kapton for the Adapter-card
- Realize the interconnection of all ASUs for a the technological prototype

# Thankyou for your kind attention







